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May 2009



### **FDMS8692**

# N-Channel PowerTrench<sup>®</sup> MOSFET 30V, 28A, 9.0m $\Omega$

#### **Features**

- Max  $r_{DS(on)}$  = 9.0m $\Omega$  at  $V_{GS}$  = 10V,  $I_D$  = 12A
- Max  $r_{DS(on)}$  = 14.0m $\Omega$  at  $V_{GS}$  = 4.5V,  $I_D$  = 10.5A
- Advanced Package and Silicon combination for low r<sub>DS(on)</sub> and high efficiency
- MSL1 robust package design
- RoHS Compliant

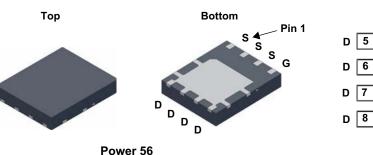


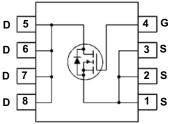
#### **General Description**

The FDMS8692 has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest  $r_{\text{DS}(\text{on})}$  while maintaining excellent switching performance.

#### **Applications**

- Low Side for Synchronous Buck to Power Core Processor
- Secondary Side Synchronous Rectifier
- Low Side Switch in POL DC/DC Converter
- Oring FET/ Load Switch





**MOSFET Maximum Ratings**  $T_A = 25^{\circ}C$  unless otherwise noted

Symbol	Parameter			Ratings	Units	
V <sub>DS</sub>	Drain to Source Voltage			30	V	
V <sub>GS</sub>	Gate to Source Voltage			±20	V	
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25°C		28		
	-Continuous (Silicon limited)	T <sub>C</sub> = 25°C		48		
ID	-Continuous	T <sub>A</sub> = 25°C	(Note 1a)	12	_ A	
	-Pulsed			120		
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	72	mJ	
Б	Power Dissipation	T <sub>C</sub> = 25°C		41	w	
P <sub>D</sub>	Power Dissipation	T <sub>A</sub> = 25°C	(Note 1a)	2.5	vv	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature R	ange		-55 to +150	°C	

#### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case		3.0	°C/W
$R_{\theta,IA}$	R <sub>A IA</sub> Thermal Resistance, Junction to Ambient		50	C/VV

#### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity	
FDMS8692	FDMS8692	Power 56	13"	12mm	3000units	

### **Electrical Characteristics** $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter Test Conditions		Min	Тур	Max	Units
Off Chara	cteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, referenced to 25°C		20		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24V,  V_{GS} = 0V$			1	μА
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA

#### On Characteristics

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1	1.8	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25°C		-5.4		mV/°C
		V <sub>GS</sub> = 10V, I <sub>D</sub> = 12A		7.0	9.0	
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 4.5, I_D = 10.5A$		10.5	14.0	mΩ
	$V_{GS} = 10V$ , $I_D = 12A$ , $T_J = 125$ °C		10.0	13.0		
9 <sub>FS</sub>	Forward Transconductance	$V_{DD} = 10V, I_D = 12A$		58		S

#### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V - 45V V - 0V		950	1265	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 0V, — f = 1MHz		515	685	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 11/11/2		85	130	pF
$R_g$	Gate Resistance	f = 1MHz		1.0	2.8	Ω

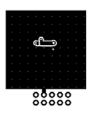
#### **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time	15111	$V_{DD} = 15V, I_{D} = 12A,$ $V_{GS} = 10V, R_{GEN} = 6\Omega$		9	18	ns
t <sub>r</sub>	Rise Time	$V_{DD} = 15V, I_D = 12A$			3	10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>GS</sub> - 10V, K <sub>GEN</sub> -			19	34	ns
t <sub>f</sub>	Fall Time				2	10	ns
$Q_g$	Total Gate Charge	V <sub>GS</sub> = 0V to 10V			15	21	nC
Qg	Total Gate Charge	V <sub>GS</sub> = 0V to 5V	V <sub>DD</sub> = 15V, I <sub>D</sub> = 12A		8	11	nC
Q <sub>gs</sub>	Gate to Source Charge		ID - 12A		2.7		nC
$Q_{gd}$	Gate to Drain "Miller" Charge				2.1		nC

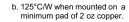
#### **Drain-Source Diode Characteristics**

V <sub>SD</sub> Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>S</sub> = 2.1A (Note 2)	0.7	1.2	V	
V <sub>SD</sub>	Source to Drain blode Forward voltage	V <sub>GS</sub> = 0V, I <sub>S</sub> = 12A	0.8	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 12A, di/dt = 100A/μs	29	47	ns
Q <sub>rr</sub>	Reverse Recovery Charge	11F - 12A, αι/αι - 100A/μS	14	25	nC

 $R_{\theta LA}$  is determined with the device mounted on a  $1\text{in}^2$  pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta LC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a. 50°C/W when mounted on a 1in<sup>2</sup> pad of 2 oz copper.





<sup>2.</sup> Pulse Test: Pulse Width <  $300\mu s$ , Duty cycle < 2.0%. 3. Starting T $_J$  =  $25^{\circ}C$ , L = 0.3mH, I $_{AS}$  = 22A, V $_{DD}$  = 30V, V $_{GS}$  = 10V.

#### Typical Characteristics T<sub>J</sub> = 25°C unless otherwise noted

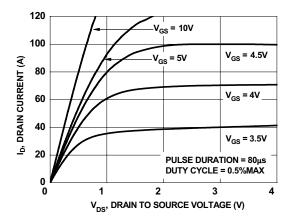


Figure 1. On-Region Characteristics

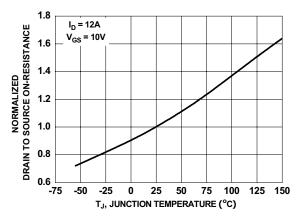


Figure 3. Normalized On-Resistance vs Junction Temperature

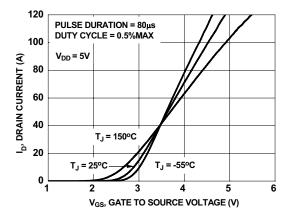


Figure 5. Transfer Characteristics

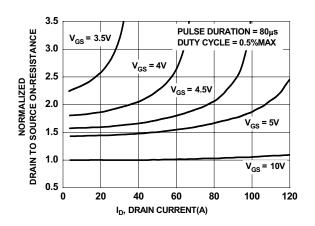


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

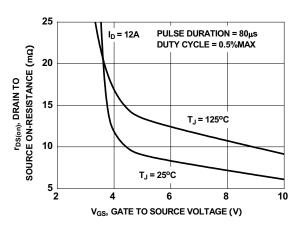


Figure 4. On-Resistance vs Gate to Source Voltage

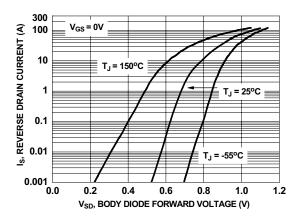


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

#### Typical Characteristics T<sub>J</sub> = 25°C unless otherwise noted

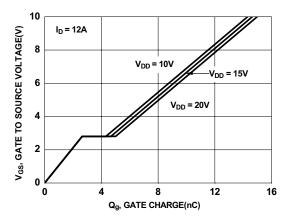


Figure 7. Gate Charge Characteristics

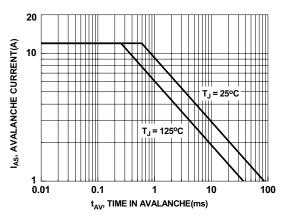


Figure 9. Unclamped Inductive Switching Capability

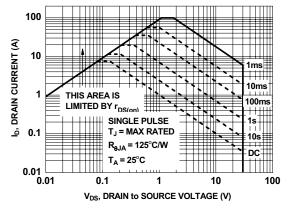


Figure 11. Forward Bias Safe Operating Area

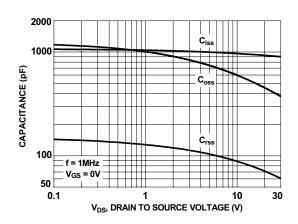


Figure 8. Capacitance vs Drain to Source Voltage

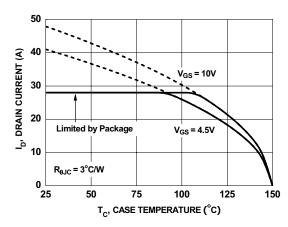


Figure 10. Maximum Continuous Drain Current vs Case Temperature

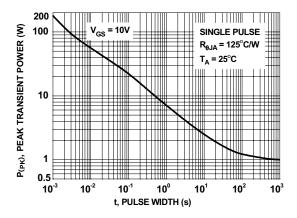


Figure 12. Single Pulse Maximum Power Dissipation

### Typical Characteristics T<sub>J</sub> = 25°C unless otherwise noted

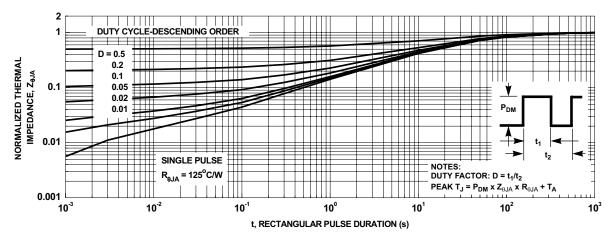
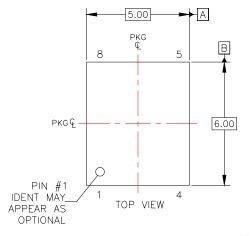
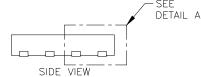
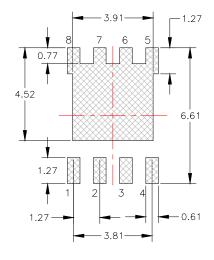


Figure 13. Transient Thermal Response Curve

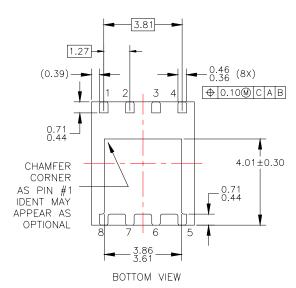
#### **Dimensional Outline and Pad Layout**

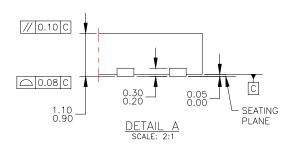


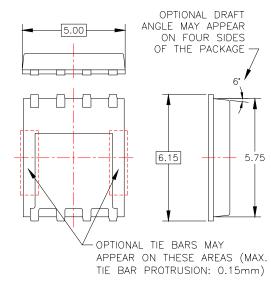












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  DIMENSIONS DO NOT INCLUDE BURRS
  OR MOLD FLASH. MOLD FLASH OR
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